

# SEARCH

Class	Sub.	Date	Exmr.
250	306 307 310 311 442.11 347 396A	2-13-64	J/L

## INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

# SEARCH NOTES

(List databases searched. Attach search strategy inside.)

	Date	Exmr.
Plus search		J/L
(Electric Mirrors)	2-13-64	J/L
on SEM on thin))	2-18-64	
And (Stereovision		
on Stereoscopic		
PARALLAX on		
(Stereo Maps		
images) on		
True Near Dimensions		
on 3D) And		
(Beam on e-beam		
on e-beam) Near		
(Tilt on Angles)		
Near (Specimen		
on Sample on Object)		
And (e-beam on		
e-beam on (Electric		
At Pen) J/L		
(Specimen on		
Sample on Object)		

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